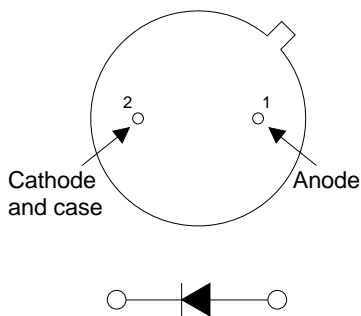
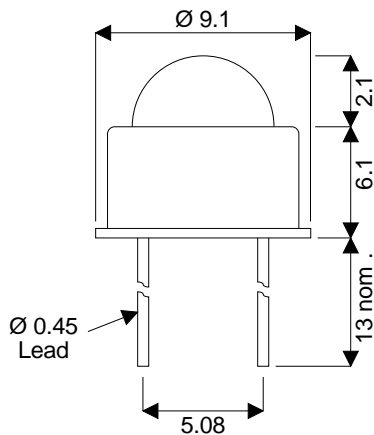


MECHANICAL DATA

Dimensions in mm.



TO-39 Package

Pin 1 – Anode

Pin 2 – Cathode & Case

P.I.N. PHOTODIODE

FEATURES

- NARROW RECEIVING ANGLES
- EXCELLENT LINEARITY
- LOW NOISE
- WIDE SPECTRAL RESPONSE
- WIDE INTRINSIC BANDWIDTH
- LOW LEAKAGE CURRENT
- LOW CAPACITANCE
- INTEGRAL OPTICAL FILTER OPTION note 1
- TO39 HERMETIC METAL CAN PACKAGE
- EMI SCREENING MESH AVAILABLE

Note 1 Contact Semelab Plc for filter options

DESCRIPTION

The SMP550G-EN is a Silicon P.I.N. photodiode incorporated in a lensed, hermetic metal can package. The electrical terminations are via two leads of diameter 0.018" on a pitch of 0.2". The cathode of the photodiode is electrically connected to the package.

The larger photodiode active area provides greater sensitivity than the SMP400 range of devices, with a corresponding reduction in speed. The photodiode structure has been optimised for high sensitivity, light measurement applications. The narrow viewing angles provide better coupling to on-axis illumination sources. The metal can and optional screening mesh ensure a rugged device with a high degree of immunity to radiated electrical interference.

ABSOLUTE MAXIMUM RATINGS (T_{case} = 25°C unless otherwise stated)

Operating temperature range	-40°C to +70°C
Storage temperature range	-45°C to +80°C
Temperature coefficient of responsivity	0.35% per °C
Temperature coefficient of dark current	x2 per 8°C rise
Reverse breakdown voltage	60V

CHARACTERISTICS ($T_{amb}=25^{\circ}C$ unless otherwise stated)

Characteristic	Test Conditions.	Min.	Typ.	Max.	Units
Responsivity	λ at 900nm	0.45	0.55		A/W
Active Area			5.19		mm ²
Dark Current	E = 0 Dark 1V Reverse		2	4	nA
	E = 0 Dark 10V Reverse		16	22	
Breakdown Voltage	E = 0 Dark 10 μ A Reverse	60	80		V
Capacitance	E = 0 Dark 0V Reverse		55		pF
	E = 0 Dark 20V Reverse		10		
Rise Time	30V Reverse 50 Ω		9		ns
NEP	900nm		19x10 ⁻¹⁴	0.45	W/ \sqrt{Hz}

